

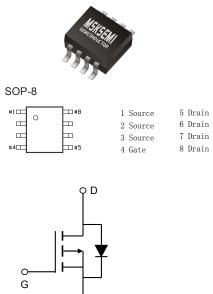


# Product data sheet

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AO4403-MS HF Compiance



#### Features

- VDS (V) =-30V
- ID =-6 A (VGS =-10V)
- Rds(on) < 48m  $\Omega$  (Vgs =-10V)
- Rds(on) < 57m Ω (Vgs =-4.5V)
- RDS(ON) < 80m Ω (VGS =-2.5V)

### Absolute Maximum Ratings Ta = $25^{\circ}$ C

δs

Parameter	Symbol	Rating	Unit		
Drain-Source Voltage		Vds	-30	V	
Gate-Source Voltage		Vgs	±12		
Continuous Drain Current	TA=25°C	١D	-6		
	Ta=70°C		-5	А	
Pulsed Drain Current	Ідм	-30	A		
Avalanche Current		las,lar	18		
Avalanche energy	L=0.1mH	Eas,Ear	16	mJ	
Dewer Dissinction	Ta=25°C	PD	3.1	w	
Power Dissipation	Ta=70°C		2	vv	
Thermal Resistance.Junction- to-Ambient	$t \le 10s$	RthJA	40		
	Steady-State		75	°C/W	
Thermal Resistance.Junction- to-Lead	RthJL	24			
Junction Temperature	TJ	150	°C		
Junction Storage Temperature Range		Tstg	-55 to 150	C	

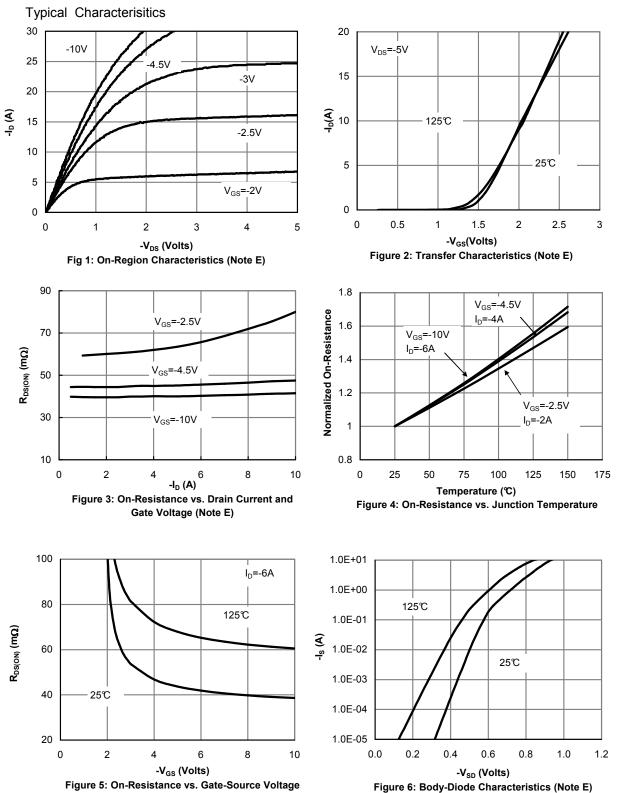


### Electrical Characteristics Ta = $25^{\circ}$ C

Parameter	Symbol	Test Conditions	Min	Тур	Max	Unit
Drain-Source Breakdown Voltage	VDSS	ID=-250 µ A, VGS=0V	-30			V
Zara Cata Valtaga Drain Current	12.00	VDS=-30V, VGS=0V			-1	uA
Zero Gate Voltage Drain Current	IDSS	VDS=-30V, VGS=0V, TJ=55°C			-5	
Gate-Body leakage current	lgss	VDS=0V, VGS=±12V			±100	nA
Gate Threshold Voltage	VGS(th)	VDS=VGS ID=-250 µ A	-0.5		-1.3	V
Static Drain-Source On-Resistance	RDS(ON)	Vgs=-10V, Id=-6A			48	
		Vgs=-10V, ID=-6A TJ=125℃			72	mΩ
		Vgs=-4.5V, ID=-4A			57	
		Vgs=-2.5V, ID=-2A			80	
On state drain current	ID(ON)	Vgs=-4.5V, Vds=-5V	-30			А
Forward Transconductance	gfs	VDS=-5V, ID=-6A		19		S
Input Capacitance	Ciss			645	780	pF
Output Capacitance	Coss	VGs=0V, VDs=-15V, f=1MHz		80		
Reverse Transfer Capacitance	Crss			55		
Gate resistance	Rg	VGS=0V, VDS=0V, f=1MHz	4		12	Ω
Total Gate Charge	Qg			7		nC
Gate Source Charge	Qgs	Vgs=-4.5V, Vds=-15V, Id=-6A		1.5		
Gate Drain Charge	Qgd			2.5		
Turn-On DelayTime	td(on)			6.5		ns
Turn-On Rise Time	tr	Vgs=-10V, Vds=-15V, RL=2.5Ω,		3.5		
Turn-Off DelayTime	td(off)	Rgen=6Ω		41		
Turn-Off Fall Time	tr			9		
Body Diode Reverse Recovery Time	trr			11		
Body Diode Reverse Recovery Charge	Qrr	IF=-6A, dı/dt=100A/us		3.5		nC
Maximum Body-Diode Continuous Current	ls				-3.5	Α
Diode Forward Voltage	Vsd	Is=-1A,VGs=0V			-1	V

Note : The static characteristics in Figures 1 to 6 are obtained using <300  $\mu s$  pulses, duty cycle 0.5% max.





AO4403-MS

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HF

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(Note E)





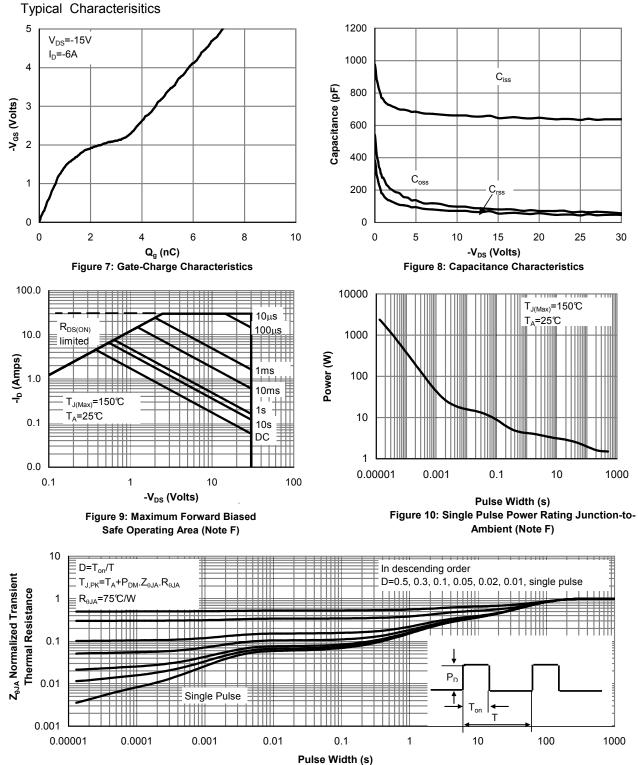
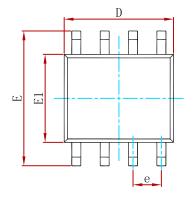


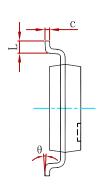
Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)

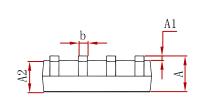


AO4403-MS HF Roms Semiconductor Compiance

## PACKAGE MECHANICAL DATA

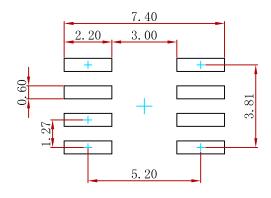






Symbol	Dimensions In Millimeters		Dimensions In Inches		
Symbol	Min	Max	Min	Max	
А	1.350	1.750	0.053	0.069	
A1	0.100	0.250	0.004	0.010	
A2	1.350	1.550	0.053	0.061	
b	0.330	0.510	0.013	0.020	
с	0.170	0.250	0.007	0.010	
D	4.800	5.000	0.189	0.197	
e	1.270	(BSC)	0.050	(BSC)	
Е	5.800	6.200	0.228	0.244	
E1	3.800	4.000	0.150	0.157	
L	0.400	1.270	0.016	0.050	
θ	0 °	8°	0 °	8°	

## Suggested Pad Layout



#### Note:

1.Controlling dimension:in millimeters.

2.General tolerance:± 0.05mm.
3.The pad layout is for reference purposes only.

## **REEL SPECIFICATION**

P/N	PKG	QTY
AO4403-MS	SOP-8	3000





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